

# Search Notes



Application/Control No.

10/050,779

Examiner

Hieu c. Le

Applicant(s)/Patent under  
Reexamination

EVARD ET AL.

Art Unit

2142

## SEARCHED

Class	Subclass	Date	Examiner
709	202,203	4/26/2005	HL
	223-224		
	242-243		
713	200-202	4/27/2005	
	155,161		
	168,190		
709	238-239		
370	236.1	4/28/2005	
379	9.02		
455	424		
340	853.2		
710	15		
714	16		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	202,223	4/28/2005	HL
	224,238		
713	200-201		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Consulted with P.E	2/26/2005	HL
Marc Thompson	2/27/2005	HL
Meky Moustafa	2/28/2005	HL
EL Hady Nabil	2/28/2005	HL